

Full Silicon Carbide Power Module

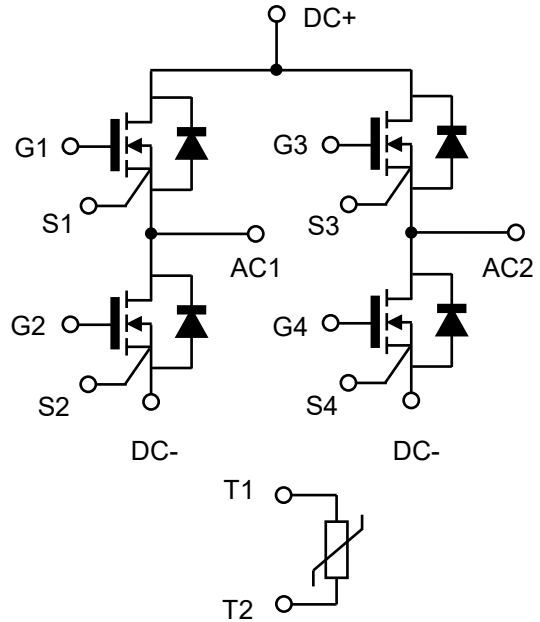
1200V, 13mΩ, Full-Bridge Topology



Product Information:



FP12013FE1FB1T



Features

- Optimized $R_{DS(on)}$ with Rapid Switching Behavior
- Build with AEC-Q101 Qualified SiC MOSFETs
- Al_2O_3 Ceramic with integrated NTC
- High Avalanche Endurance Capability
- Pre-Applied Thermal Interface Material (Optional)
- Optimized for High Power Density Applications
- RoHS Compliant and Halogen Free

Benefits

- Higher System Efficiency
- Industrial Standard Package Pin-out
- Enable High Temperature Application
- Allow High Frequency Operation
- Realize Compact and Lightweight Systems
- High Reliability

Potential Applications

- Uninterruptible Power Supplies
- Renewables
- EV Fast Charging Stations
- Industrial Power
- Power Inverter

Key Performance Parameters

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS} @ T_{j(max)}$	1200	V
Recommended Gate-Source Turn-On Voltage	V_{GS}	18V	
Drain-Source On-State Resistance	$R_{DS(on)}$	13	mΩ
Nominal Drain Current	$I_{D, nom}$	127	A
Pulse Drain Current	$I_{D, pulse}$	478	
Avalanche Energy	E_{AS}	2700	mJ
Gate Charge	Q_G	382	nC
Output Capacitive Charge	Q_{oss}	290	
Junction & Storage Temperature	T_j, T_{stg}	-55 to 175	°C

Part Number	Package	Marking
FP12030FE1FB1T	FE1 Package + TIM	FP12030FE1FB1T

For further information about comparable products, please contact (www.fastsic.com).

Maximum Ratings: ($T_j = 25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Voltage	V_{DSS}	1200	--	--	V	$V_{GS}=0\text{V}$
Continuous Drain Current	I_D	--	--	127 91	A	$V_{GS}=18\text{V}, T_c=25^\circ\text{C}$ $V_{GS}=18\text{V}, T_c=100^\circ\text{C}$
Pulse Drain Current	$I_{D,pulse}$	--	--	478		$T_c=25^\circ\text{C}$, per Fig.13
Operate Gate Source Voltage	$V_{GS,op}$	-10~0	--	15~18	V	Recommended operating values
Transient Gate Source Voltage	$V_{GS,tran.}$	-12	--	21		Transient operating limit (AC $f > 1\text{Hz}$, pulse width $< 100\text{ns}$)
Power Dissipation	P_{tot}	--	--	555	W	$T_c=25^\circ\text{C}$

Electrical Characteristics:

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
DC Characteristics (at $T_j = 25^\circ\text{C}$, unless otherwise specified)						
Drain-source Breakdown Voltage	$V_{(BR)DSS}$	1200 --	-- 1200	-- --	V	$V_{GS}=0\text{V}, T_j=25^\circ\text{C}$ $V_{GS}=0\text{V}, T_j=175^\circ\text{C}$
Drain-Source On-State Resistance	$R_{DS(on)}$	--	12.4 13.8	-- --	m Ω	$V_{GS}=18\text{V}, I_D=50\text{A}, T_j=25^\circ\text{C}$ $V_{GS}=15\text{V}, I_D=50\text{A}, T_j=25^\circ\text{C}$
Gate-Source Threshold Voltage	V_{th}		2.5		V	$V_{GS}=V_{DS}, I_D=100\text{mA}$
Zero Gate Voltage Drain Current	I_{DSS}	--	1	100	μA	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$
Gate-Source Leakage Current	I_{GSS}	--	--	100	nA	$V_{GS}=18\text{V}, V_{DS}=0\text{V}$
Internal Gate Resistance	$R_{G,int.}$	--	1.5	--	Ω	$f=1\text{MHz}, V_{AC}=25\text{mV}$
Body Diode Forward Voltage	V_{SD}	--	2.8 2.5		V	$V_{GS}=0\text{V}, I_S=30\text{A}, T_j=25^\circ\text{C}$ $V_{GS}=0\text{V}, I_S=30\text{A}, T_j=100^\circ\text{C}$
AC Characteristics (at $T_j = 25^\circ\text{C}$, unless otherwise specified)						
Input Capacitance	C_{iss}	--	7653	--	pF	$V_{DS}=800\text{V}, V_{GS}=0\text{V},$ $f=250\text{kHz}, V_{AC}=25\text{mV}$
Output Capacitance	C_{oss}	--	203	--		
Reverse Capacitance	C_{rss}	--	9.7	--		
Effective Output Capacitance, energy related	$C_{o(er)}^1$	--	241	--		
Effective Output Capacitance, time related	$C_{o(tr)}^2$	--	337	--		
C_{oss} Stored Energy	E_{oss}	--	81.6	--		
Output Capacitive Charge	Q_{oss}	--	290	--	μC	

¹ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 800V.

² $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 800V.

Switching Characteristics:

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Gate Characteristics						
Gate to Source Charge	Q_{GS}	--	68	--	nC	$V_{DS}=800V, V_{GS}=0V/18V, I_D=50A$
Gate to Drain Charge	Q_{GD}	--	146	--		
Total Gate Charge	Q_G	--	382	--		

Thermal Characteristics:

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Thermal Resistance, junction-to-Heatsink	R_{th-jh}	--	0.20		K/W	
Maximum junction Temperature	$T_{j,max}$	-40		175	°C	
Operating Temperature	$T_{vj,op}$	-40		150		
Storage Temperature	T_{stg}	-40		125		

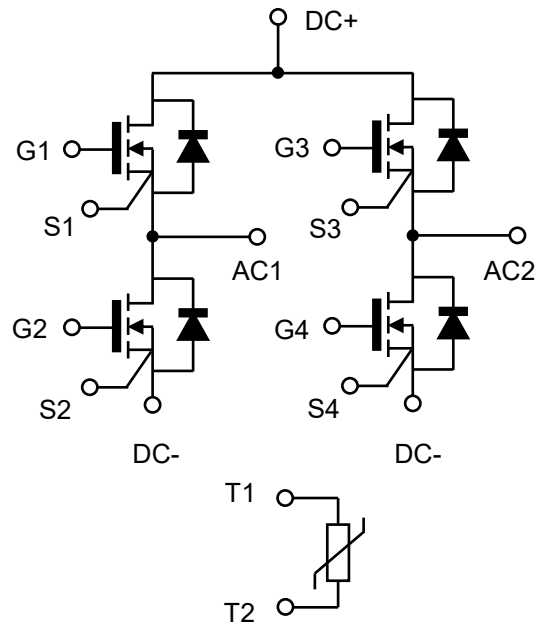
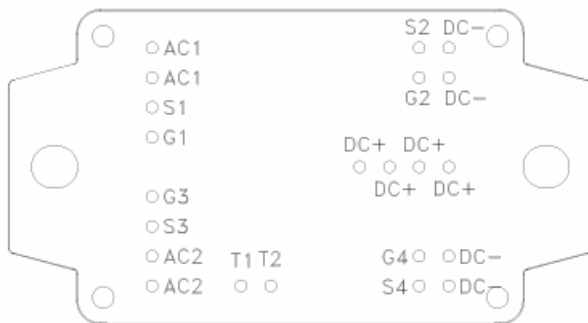
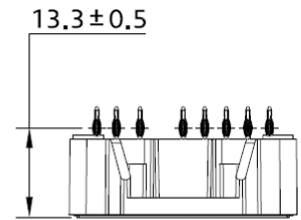
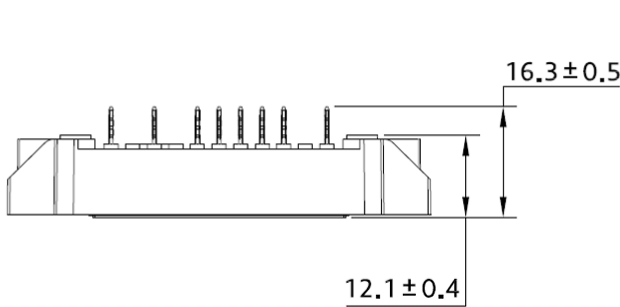
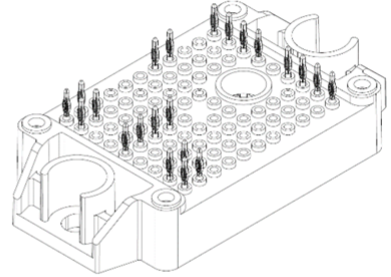
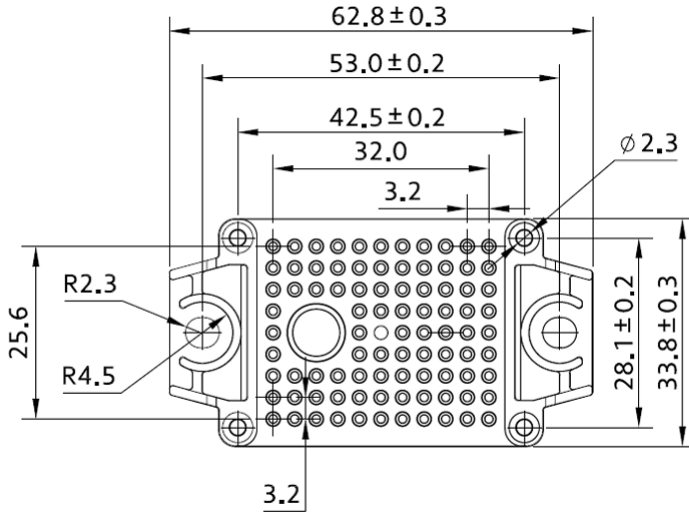
NTC Characteristics:

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Resistance	R_{25}		5		kΩ	
B-value	B_{25_150}		3375		K	$R^* = R_{25} \exp [B_{25_150}(1/T^* - 1/(298.15K))]$

Package Characteristics:

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Isolation Test Voltage	V_{isol}	4			kV	AC, 50Hz (R.M.S), $t=1$ minute
Stray Inductance	L_{sDS}		15		nH	
Comparative Tracking Index	CTI	400		600	--	IEC 60112 Cat. II
Weight	G				g	

Package Outline



Note:

1. The information provided herein is subject to change without notice.
2. For other information that does not show on this datasheet, please contact us for inquiry.

Revision History

Date	Revision	Changes
26.04	Tentative	1 st issue

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